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Impact mass flow sensor for monitoring peanut harvest yields

Kendall R. Kirk

J. Warren White

W. Scott Monfort

Hunter F. Massey

D. Hollens

See next page for additional authors

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Recommended Citation

Kirk, Kendall R.; White, J. Warren; Monfort, W. Scott; Massey, Hunter F.; Hollens, D.; Brantley, Stanley A.; Peele, Joel S.; Fravel, Jacob B.; and Henderson, William G. Jr., "Impact mass flow sensor for monitoring peanut harvest yields" (2018). *Clemson Patents*. 599.
https://tigerprints.clemson.edu/clemson_patents/599

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Authors

Kendall R. Kirk, J. Warren White, W. Scott Monfort, Hunter F. Massey, D. Hollens, Stanley A. Brantley, Joel S. Peele, Jacob B. Fravel, and William G. Henderson Jr.



US009958301B2

(12) **United States Patent**
Kirk et al.

(10) **Patent No.:** **US 9,958,301 B2**
(45) **Date of Patent:** **May 1, 2018**

(54) **IMPACT MASS FLOW SENSOR FOR MONITORING PEANUT HARVEST YIELDS**

(58) **Field of Classification Search**
CPC G01F 1/30; G01F 1/00; G01F 1/28; A01D 75/00; A01D 29/00; A01D 2033/005; G01L 5/0076; G01L 3/24; B60R 2021/01516
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(71) Applicants: **Clemson University**, Clemson, SC (US); **Amadas Industries, Inc.**, Suffolk, VA (US)

(72) Inventors: **Kendall R. Kirk**, Pendleton, SC (US); **J. Warren White**, Suffolk, VA (US); **W. Scott Monfort**, Aiken, SC (US); **Hunter F. Massey**, Liberty, SC (US); **D. Hollens Free**, Blackville, SC (US); **Stanley A. Brantley**, Suffolk, VA (US); **Joel S. Peele**, Suffolk, VA (US); **Jacob B. Fravel**, Central, SC (US); **William G. Henderson, Jr.**, Warrenton, SC (US)

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Primary Examiner — Lisa Caputo
Assistant Examiner — Nigel Plumb

(73) Assignee: **Clemson University**, Clemson, SC (US)

(*) Notice: Subject to any disclaimer, the term of this patent is extended or adjusted under 35 U.S.C. 154(b) by 149 days.

(21) Appl. No.: **14/795,323**

(22) Filed: **Jul. 9, 2015**

(65) **Prior Publication Data**
US 2016/0011024 A1 Jan. 14, 2016

Related U.S. Application Data

(60) Provisional application No. 62/023,275, filed on Jul. 11, 2014.

(51) **Int. Cl.**
G01F 1/30 (2006.01)
A01D 29/00 (2006.01)
(Continued)

(52) **U.S. Cl.**
CPC **G01F 1/30** (2013.01); **A01D 29/00** (2013.01); **A01D 41/1272** (2013.01); **A01D 2033/005** (2013.01)

(57) **ABSTRACT**

Yield monitoring systems for harvesting machines and methods that can provide yield monitoring of crops are described. Machines include those that pneumatically convey crop through the machine such as peanut harvesting machines. The yield monitoring system includes a force sensor that can be located in conjunction with a duct of the harvesting machine such that impact of the crop materials on an impact plate within the duct will be registered by the force sensor. This registration can be used to determine a mass flow rate for the crop, which can be correlated to yield of the crop. The systems can include additional components such as optical monitors, moisture sensors, and pressure sensors.

24 Claims, 15 Drawing Sheets

